> exposed regions dissolve in

positive photoresist.

developed

unexposed regions dissalve in developer (negative photoresist)

The safe of photonesists is to transfer the required circuit patem on to the substrate and also act as an otch basiles on the substrate whom subjected to etching in the required regions. Therefore

The requirements of for boot porformance of

- Exposure spend and sensitivity? The primary action of a photogenist is a change in structure in response to an exposing light.

The rate of the seachon should be high so that the waters can be processed faster.

Negative Photoresists require 5 to 15 Leconds I exposure time, whereas positive rasists take three

to four times longer.

Adhesion capability!

Since it was photoresists also act as otch barriers, the materials should be strongly adherent on the Eabstrate. The layer should be free from pinholes and also should have a certain thickness for mechanical strength.

If the layer does not adhere strongly to the substrate, the pattern will be distorted leading to defect.

-> Resolution capability:

For fabrication of VLSI circuits the resolution capability If a photorexist should be light as small as possible.

The smallest opening or space that can be produced on a photoresist is called as resolution capability. The smaller the opening produced, the better the resolution capability.

Generally, smaller line openings are produced with thinner regist film thickness. However, a regist layer must be thick enough to function as an etch barrier and be pinholo free.

Resist Pesist I thickness (T)

Swidth of the space or opening

Aspect valio = 15 T

openings with thicker layers. Poritive photoresists have higher aspect ratios compared to negative photoresists.

-> Viscosity:

Usually photoresists are wated by a on substrates by spin wating. The visusity of the photoresist suspension plays an important role in obtaining fit layers of the required thickness and the process time.

-) thermal flows Retain dimensional etability

During patterning the photoresist is subjected to two healing steps. The first healing is called soft bake which evaporates solvents from the resist. The second one is the hard bake, which is done after the image has been developed in the resist layer. The purpose of the hard bake is to increase the adhesion of the resist to the wafer surface.

since the gresist is a polymer, it may soften and flow (Depending on its Tg) during the hard bake step. Such alimensional changes may lead to defect. Therefore, the resist has to maintain its shape and structure cluring the hard-bake step.

Structure cluring the hard-bake step.

Regists, like other process chemicals, must be meet stringent standards for particle content, Rodium and frace metal contaminants and water content.

Precautions to be taken during storage and use of photoneristan

- -> since photosesists are light sensitive materials, throughouse to be protected alusing storage and handling.

 This is copy masking areas use yellow light and resists are stored in brown bottles.
- To maintain photosesist viscosity, resist bottles must be capped prior to use. Otherwise, solvents will a vaporate and viscosity would increase.
- Each photoresist has a shelf life. As time passes, changes in the polymer will take place, attering the resist performance.
- For proper adhesion of the photoresist to the substrate, the substrate should be free from contaminants and moisture. The relative humicility in the wafer fabrication area is kept under control so that moisture aloes not collect on the substrate.

A dehydration baking is done on the water to remove maisture and a hydrophobic wating is ofiven on the substrate to promote adhesion of photosexist.

-> The regist dispensing take must be free from estid regist materials, that me Thus pheriodic cleaning is required.

Positive photoresists:

Material which shows an increase in solubility of the resist in the light exposed region relative to the unexposed

Eg 1: A pholoresist that is widely used in the electronics industry is a two-component system comprising a short chain Novolac resin, which acts as the film forming agent, mixed with 20 to 50 wt/o of a naphthaquinone diazide photosensitive compound. This sensitizes is insoluble in basic solutions and asks by intribition also inhibits the dissolution of the novolac resin in base a novolac itself is soluble in altali).

naphthaquinone diazide (insoluble in base)

sensitizer gets converted on exposure to light, the to indene carboxylic acid.

sae has uveight

Indene carboxylic acid bocomes soluble in

Therefore at the light exposed region, novolac & the indecarboxylic acid discreformed, dissolve in alkali.

Eg. (Polymethylmethronylate (PMMA). In this case, the carbonyl groups absorb at 215 nm, and this leads to chain seission and degradation.

$$-cH_{2}-cH_{3}$$

Negative phelorosist :-

Material shows increased establishy in unexpessed regions.

Fg. 2. post simamate vinyl polymess containing cinnamate groups.

companison between positive and negative photoresiste

- > Positive photoresist is preferred for image rizes in the 2 to 5 flm or lower sange because they have higher resists.
- I regalive resists are more sensitive to on in atmosphere.
- J. Positive resists are more expensive than megative.
- the difference in solubility of the weight material between the exposed and renoxposed regions of the regist material is large, in the case of negative photographs. The dimensions of images formed photographs. The dimensions of images formed is stable even after developing. etcp.

But the difference is solubility between the exposed and exposed regions is very less in the case of phenoresists. ... carefully prepared developed solutions are required or dissolution inhibitors are required.

-) Generally, the removal of positive potoresist in unexposed region is easier and takes place in chemicals that are more ecofriendly.